Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/611,743	FAIN ET AL.	
Examiner	Art Unit	
Timothy H. Meeks	1762	

	SEARCHED				
Class	Subclass	Date	Examiner		
427	237	11/15/2004	ТНМ		
	248.1				
	255.7				
	255.34				
	255.36				
	255.391				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	I				
			1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST, parent checked	11/15/2004	ТНМ	